

Notice of References Cited

Application/Control No.

10/562,577

Applicant(s)/Patent Under
Reexamination
HEMBD, CHRISTIAN

Examiner

Arnel C. Lavarías

Art Unit

2872

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,643,534	02-1987	Chun et al.	359/249
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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